Search Notes



Application/Control No.	Applicant(s)/Patent Under Reexamination
10718484	BASTING ET AL.
Examiner	Art Unit
Detschel, Marissa J	2886

SEARCHED						
Class	Subclass	Date	Examiner			
356	450, 454, 519	3/1/07	MJD			

SEARCH NOTES				
Search Notes	Date	Examiner		
Inventors search	3/1/07	MJD		
Consulted Sam Turner and Andrew Lee on search and case	3/6/07	MJD		
EAST search terms: pixel, degradation, damage\$, defect\$, fringe, interference, correct\$, sensitivity	3/2/07	MJD		

INTERFERENCE SEARCH						
Class	Subclass	Date	Examiner			

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